

Notice of References Cited

Application/Control No.

10/535,284

Applicant(s)/Patent Under
Reexamination
KIRENKO ET AL.

Examiner

Jared Beltowski

Art Unit

2621

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0233464	12-2003	Walpole et al.	709/231
	B	US-			
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NON-PATENT DOCUMENTS

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